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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,048	REID, CHRISTOPHER Q.	
Examiner	Art Unit	
Richale L. Haney	3765	

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Class	Subclass	Date	Examiner
02	160,164,1 59,158,16 1.6,161.1,	8/31/2005	RLH
02	161.4	8/31/2005	RLH

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SE	CH NOTES EARCH STRATEGY	<u>()</u>
	DATE	EXMR
See EAST report	8/31/2005	RLH
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